## BREAKTHROUGH IN THE LIFETIME OF MICROCHANNEL-PLATE PMTS







- CONTEXT: DIRC DETECTORS FOR PANDA AT FAIR
- CHALLENGE: STATUS IN 2011
- MCP-PMT LIFETIME IMPROVEMENT

APPROACHES AGING TESTS

• SUMMARY AND OUTLOOK

For more detail see A. Lehmann's talk at LIGHT14 https://conference.mpp.mpg.de/light-14/



## PANDA AT FAIR







J. Schwiening, IEEE NSS N36.1, Nov 2014



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**PANDA:** rich program of QCD studies using anti-proton beam with unique intensity and precision.

Hadronic Particle ID: two DIRC detectors

• Barrel DIRC – similar to BABAR DIRC with several key improvements.

Goal:  $3\sigma \pi/K$  separation for p=0.5...3.5 GeV/c.

• Novel Endcap Disk DIRC

Goal:  $3\sigma \pi/K$  separation for p=0.5...4.0 GeV/c.

### PANDA Cherenkov Group:

JINR Dubna, FAU Erlangen-Nürnberg, JLU Gießen, U. Glasgow, GSI Darmstadt, HIM and JGU Mainz, SMI OeAW Vienna.

For more info on the Barrel DIRC see M. Zühlsdorf talk N41-8 today









# PANDA DIRCs require compact, fast multi-pixel sensor with single photon sensitivity in strong magnetic field with trigger-less DAQ and 20MHz average interaction rate.

• Good geometrical resolution over a large surface multi-pixel sensors with ~5x5 mm anodes

(much finer segmentation needed for Endcap Disk DIRC, ••••••) 0.5mm anode pitch prototype being tested, see J. Rieke, poster N24-31)

- Single photon detection inside B-field high gain (> 5×10<sup>5</sup>) at 1-2 Tesla
- Time resolution for photon time of propagation and/or dispersion correction very good time resolution of <100 ps for single photons
- Few photons per track

high detection efficiency PDE = QE \* CE \* GE low dark count rate

• Photon rates in the MHz regime

high rate capability with rates up to MHz/cm<sup>2</sup> long lifetime with integrated anode charge of 0.5 to 2 C/cm<sup>2</sup>/y Hamamatsu 6x128 PHOTONIS 3x100







PANDA Barrel DIRC Prototype



## **DIRC SENSOR CANDIDATES**



### • Multi-anode Photomultipliers (MaPMTs)

used successfully in DIRC prototypes, was sensor of choice for SuperB FDIRC ruled out by 1T magnetic field





• Geiger-mode Avalanche Photo Diodes (SiPMs)

high dark count rate problematic for reconstruction (trigger-less DAQ) radiation hardness an issue in PANDA environment

• Micro-channel Plate Photomultipliers (MCP-PMTs)

good PDE, excellent timing and magnetic field performance issues with rate capability and aging







## **MCP-PMT PERFORMANCE EXAMPLES**





#### Detailed study of MCP-PMT performance:

- prototypes from BINP, PHOTONIS, Hamamatsu
- single photon time resolution
- gain and quantum efficiency scans
- charge sharing/cross-talk
- rate capability
- tests with and without magnetic field

#### MCP-PMTs meet *most* PANDA DIRC goals.



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## The main issue with using MCP-PMTs for PANDA DIRCs:

aging of photocathode

Status of our MCP-PMT lifetime measurements in 2011









## The main issue with using MCP-PMTs for PANDA DIRCs:

aging of photocathode



None of the MCP-PMTs in 2011 would have survived for more than 2 months in PANDA.  $\rightarrow$  needed factor ~50 ("breakthrough") improvement in MCP-PMT lifetime



## MCP-PMT AGING



## Ion feedback



- Ionization of residual gas atoms
- Desorption of atoms from MCP material (especially H and Pb)
- Damaging of MCP surfaces  $\rightarrow$  gain may change
- Ions accelerated towards photo cathode
  - Production of secondary pulse
  - Ions may react with PC
  - PC gets damaged and work function may gradually change
  - Degradation of Quantum efficiency (QE)

## Neutral molecules from residual gas

Passing between MCPs and walls

 $CO_2$ ,  $O_2$  and  $H_2O$  react with PC







- Stop feedback ions by thin Al<sub>2</sub>O<sub>3</sub> film (5-10 nm) Initially in front of first MCP layer (loss of CE) Later between MCP layers (need higher HV)
- Improve vacuum quality
- Improve cleaning of MCP surfaces Electron scrubbing
- Improve ceramics, seal off anode region Block flow of neutral molecules from anode region
- More resistant photocathode

Na<sub>2</sub>KSb(Cs), Na<sub>2</sub>KSb(Cs)+Cs, Na<sub>2</sub>KSb(Cs)+Cs<sub>3</sub>Sb

- Deposition of ultra-thin atomic layer (MgO, Al<sub>2</sub>O<sub>3</sub>) on MCP substrate (ALD)
- Use of alternate substrate material?
- Ion suppression grid between MCP and photocathode?





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Simultaneously age all MCP-PMTs at rates comparable to PANDA DIRC environment

- common systematics, results easy to compare and interpret
- continuous illumination (460nm LED, 0.25-1MHz rate, single photon level)
- permanent monitoring (MCP pulse heights, LED intensity)
- frequent QE mesurements (250-700nm, monochromator)
- setup in operation for more than three years started with standard MCP-PMTs lifetime-improved MCP-PMTs ~3 years ago







## MCP-PMT AGING MEASUREMENTS





## Summary of MCP-PMTs measured in setup



	BINP		PHOTONIS			Hamamatsu	
			XP85012	XP85112	XP85112	R10754X-01-M16	R10754X-07-M16M
pore size (µm)	6	7	25	10	10	10	10
number of pixels	1	1	8x8	8x8	8x8	4x4	4x4
active area (mm²)	9² π	9² π	53x53	53x53	53x53	22x22	22x22
total area (mm²)	15.5² π	15.5² π	59x59	59x59	59x59	27.5x27.5	27.5x27.5
geom. efficiency (%)	36	36	81	81	81	61	61
photo cathode	multi-alkali		bi-alkali			multi-alkali	
peak Q.E.	21% @ 495 nm	21% @ 495 nm	20% @ 380 nm	23% @ 380 nm	22% @ 380 nm	21% @ 375 nm	22% @ 415 nm
comm ents		better vacuum, new cathode	better vacuum, polished surfaces	better vacuum, polished surfaces	better vacuum, ALD surfaces	protection layer between MCPs	further improved lifetime (ALD)
# of tubes measured	1	2	1	1	3	1 (+1 L4)	2
		0					

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## MCP-PMT AGING MEASUREMENTS





## Summary of MCP-PMTs measured in setup



		Integrated charge	Diff. charge# of(maximum)measurement		# of QE	
	Sensor ID	(as of Oct. 1, 2014)				Comments
		[mC/cm <sup>2</sup> ]	[mC/cm <sup>2</sup> /d] s		scalls	
PHOTONIS XP85112	9001223	7852	13.5	151	14	Start: 23 Aug. 11 ongoing
	9001332	4948	21.8	55	7	Start: 12 Dec. 12 ongoing
	9001393	1879	11	19	3	Start: 23 Jan. 14 ongoing
Hamamatsu R10754X	JT0117 (M16)	<b>20</b> 86	14.1	86	7	Start: 23 Aug. 11 Stop: 24 Jul. 12
	KT0001 (M16M)	4331	30.1	31	5	Start: 20 Aug. 13 ongoing
	KT0002 (M16M)	2312	20.1	26	6	Start: 21 Oct. 13 ongoing
BINP	1359	3616	10.6	90	8	Start: 21 Oct. 11 Stop: 06 May 13
	3548	5925	11.8	128	11	Start: 21 Oct. 11 ongoing





## **MCP-PMT LIFETIME RESULTS**





Latest MCP-PMTs with ALD technique meet all requirements for the PANDA Barrel DIRC.





Impossible to describe all our results (3+ years) or the excellent MCP-PMT lifetime studies by Belle II and TORCH groups in this talk.

In the remaining time: a few highlights

For a more complete review: A. Lehmann's talks at RICH 2013 and at LIGHT14

Gain vs. integrated anode charge



 $\rightarrow$  Only moderate gain changes, can be recovered by raising HV







#### Quantum efficiency for different wavelengths vs. integrated charge



Hamamatsu film: QE drops significantly after  $\sim 1 \text{ C/cm}^2$ 

Hamamatsu ALD: only minor QE degradation at >4 C/cm<sup>2</sup>







#### Quantum efficiency for different wavelengths vs. integrated charge



#### PHOTONIS Planacon with 1 layer ALD: no QE loss up to 5 C/cm<sup>2</sup>

#### #9001223: steep QE drop after 6 C/cm<sup>2</sup>

Latest Planacon with unfired lead glass, 2-layer ALD process: no QE loss yet at 2 C/cm<sup>2</sup>.







### Quantum efficiency scans (372nm) for different integrated charges

#### film Hamamatsu R10754X-M16



#### new PC BINP 3548



 $\rightarrow$  QE degradation evolves from rims and corners, both film and new PC fail.







#### Quantum efficiency scans (372nm) for different integrated charges





 $\rightarrow$  no visible QE degradation up to 6C/cm<sup>2</sup>, loss limited to illuminated half.





## **MCP-PMT LIFETIME RESULTS**



#### Relative quantum efficiency for different wavelengths vs. integrated charge



 $\rightarrow$  Clear difference in wavelength-dependent aging between different methods.







#### Spectacular lifetime increase of latest MCP-PMTs due to recent design improvements.

Equipping the two PANDA DIRCs and other high rate RICH counters (TOP, TORCH, DIRC@EIC,...) with MCP-PMTs seems possible.



Application of ALD technique appears to be most promising single step (>5 C/cm<sup>2</sup> anode charge now feasible).

Similar good performance observed in R&D for Belle II TOP and for TORCH.

Further improvements could possibly be reached by combining ALD with

- modified photo cathodes (see BINP tubes);
- MCP materials with less outgassing (e.g. borosilicate glass instead of lead glass).

See presentations at RICH 2013 K. Matsuoka, T. Gys, J. Milnes